

OBSOLETE PRODUCT  
 POSSIBLE SUBSTITUTE PRODUCT  
 DG445, DG442

March 2000

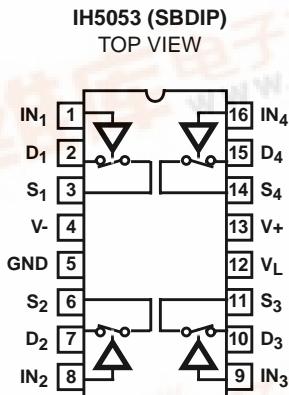
File Number 3131.3

## Quad CMOS Analog Switch

The IH5053 analog switch uses an improved, high voltage CMOS technology, which provides performance advantages not previously available from solid state switches. Key performance advantages are TTL compatibility and ultra low-power operation. The quiescent current requirement is less than 10 $\mu$ A.

The IH5053 also guarantees Break-Before-Make switching. This is accomplished by extending the  $t_{ON}$  time (1000ns) such that it exceeds the  $t_{OFF}$  time (500ns). This insures that an ON channel will be turned OFF before an OFF channel can turn ON, and eliminates the need for external logic required to avoid channel to channel shorting during switching.

## Pinout



SWITCH STATES SHOWN FOR LOGIC "1" INPUT

### TRUTH TABLE

LOGIC	SWITCHES
0	Off
1	On

## Features

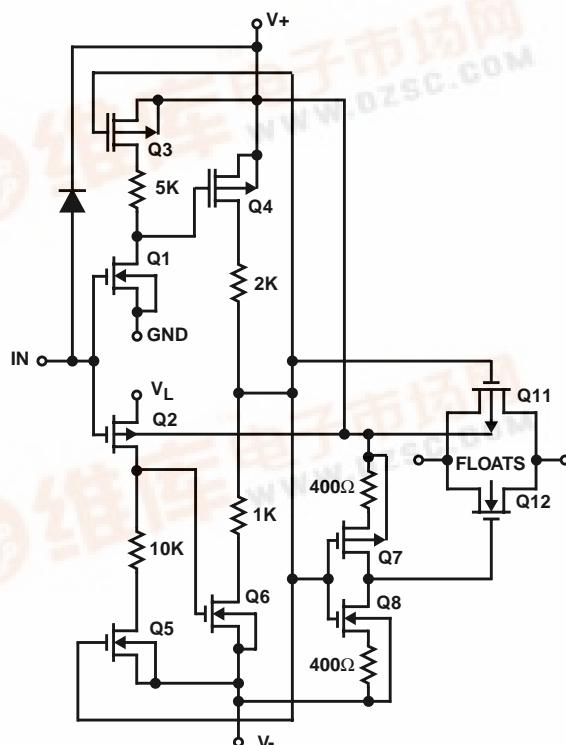
- Switches Greater Than 20V<sub>P-P</sub> Signals with  $\pm 15$ V Supplies
- Quiescent Current .....  $<10\mu$ A
- Break-Before-Make Switching
  - $t_{OFF}$  ..... 500ns
  - $t_{ON}$  ..... 1000ns
- TTL, CMOS Compatible
- 4 Normally Open Switches
- Low  $r_{DS(ON)}$  (Typ) ..... 80 $\Omega$

## Part Number Information

PART NUMBER	TEMP. RANGE (°C)	PACKAGE	PKG. NO.
IH5053CDE	0 to 70	16 Ld SBDIP	D16.3

## Schematic Diagram

(1/4 AS SHOWN)



# IH5053

## Absolute Maximum Ratings

V+ to V- . . . . .	<36V
V+ to V <sub>D</sub> . . . . .	<30V
V <sub>D</sub> to V- . . . . .	<30V
V <sub>D</sub> to V <sub>S</sub> . . . . .	<±22V
V <sub>L</sub> to V- . . . . .	<33V
V <sub>L</sub> to V <sub>IN</sub> . . . . .	<30V
V <sub>L</sub> to GND . . . . .	<20V
V <sub>IN</sub> to GND . . . . .	<20V
Continuous Current (S-D) . . . . .	30mA
Peak Current IN or OUT (Pulsed 1ms, 10% Duty Cycle, Max) . . . . .	70mA

## Thermal Information

Maximum Junction Temperature . . . . .	175°C
Maximum Storage Temperature Range . . . . .	-65°C to 150°C
Maximum Lead Temperature (Soldering 10s) . . . . .	300°C

## Operating Conditions

Temperature Range . . . . .	0°C to 70°C
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CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

## Electrical Specifications V<sub>+</sub> = +15V, V<sub>-</sub> = -15V, V<sub>L</sub> = +5V

PER CHANNEL PARAMETER	TEST CONDITIONS	(NOTES 1, 2)			UNITS
		0°C	25°C	70°C	
<b>DYNAMIC CHARACTERISTICS</b>					
Turn ON Time, t <sub>ON</sub>	R <sub>L</sub> = 1kΩ, V <sub>ANALOG</sub> = -10V to +10V (Figure 6)	-	1000	-	ns
Turn OFF Time, t <sub>OFF</sub>		-	500	-	ns
Charge Injection, Q	Figure 7	-	20 (Typ)	-	mV
OFF Isolation, OIRR	f = 1MHz, R <sub>L</sub> = 100Ω, C <sub>L</sub> ≤ 5pF (Figure 4)	-	50 (Typ)	-	dB
Crosstalk, CCRR	One Channel Off (Figure 3)	-	50 (Typ)	-	dB
<b>DIGITAL INPUT CHARACTERISTICS</b>					
Input Logic Current, I <sub>IN(ON)</sub>	V <sub>IN</sub> = 2.4V	-	±10	-	µA
Input Logic Current, I <sub>IN(OFF)</sub>	V <sub>IN</sub> = 0.8V	-	±10	-	µA
<b>ANALOG SWITCH CHARACTERISTICS</b>					
Drain-Source ON Resistance, r <sub>DS(ON)</sub>	I <sub>S</sub> = 10mA, V <sub>ANALOG</sub> = -10V to +10V	80	80	100	Ω
Channel-to-Channel, r <sub>DS(ON)</sub> Match		-	30 (Typ)	-	Ω
Minimum Analog Signal Handling Capability, V <sub>ANALOG</sub>		-	±10 (Typ)	-	V
Switch OFF Leakage Current, I <sub>D(OFF)</sub> , I <sub>S(OFF)</sub>	V <sub>ANALOG</sub> = -10V to +10V	-	±5	100	nA
Switch ON Leakage Current, I <sub>D(ON)</sub> + I <sub>S(ON)</sub>	V <sub>D</sub> = V <sub>S</sub> = -10V to +10V	-	±10	100	nA
<b>POWER SUPPLY CHARACTERISTICS</b>					
+ Power Supply Quiescent Current, I <sub>+</sub>		10	10	100	µA
- Power Supply Quiescent Current, I <sub>-</sub>		10	10	100	µA
+5V Supply Quiescent Current, I <sub>L</sub>		10	10	100	µA

### NOTES:

1. Typical values are for Design Aid only, not guaranteed nor production tested.
2. Min or Max value unless otherwise specified.

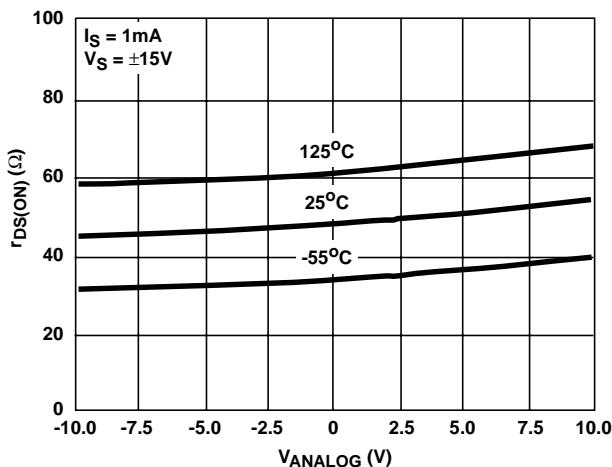
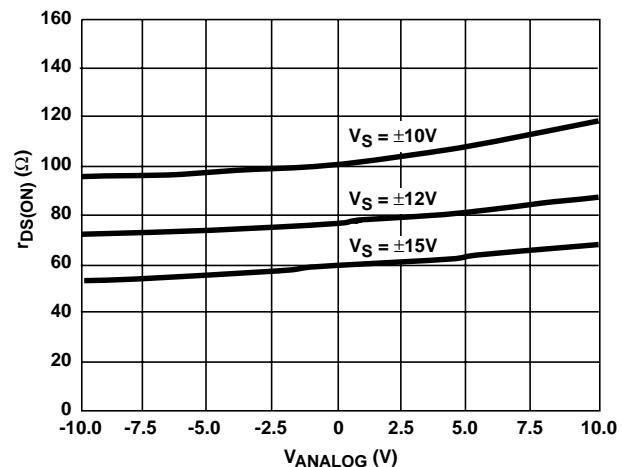
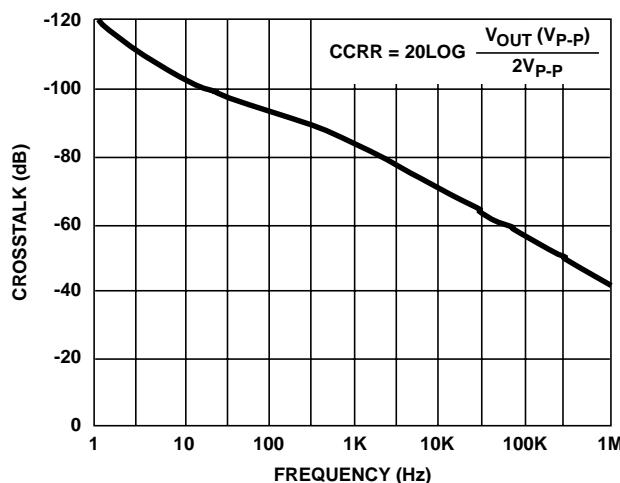
**Test Circuits and Waveforms**FIGURE 1.  $r_{DS(ON)}$  vs ANALOG INPUT VOLTAGEFIGURE 2.  $r_{DS(ON)}$  vs POWER SUPPLY VOLTAGE

FIGURE 3A. CROSSTALK vs FREQUENCY

FIGURE 3. CROSSTALK

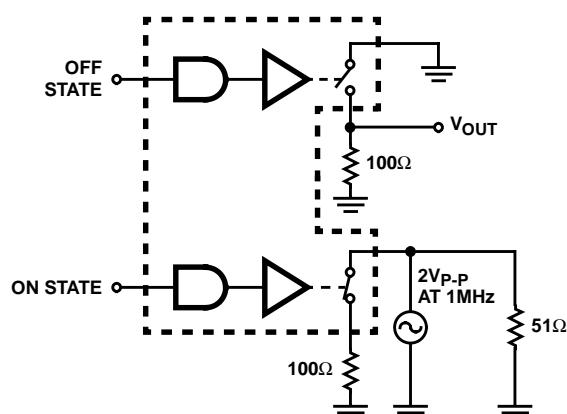


FIGURE 3B. TEST CIRCUIT

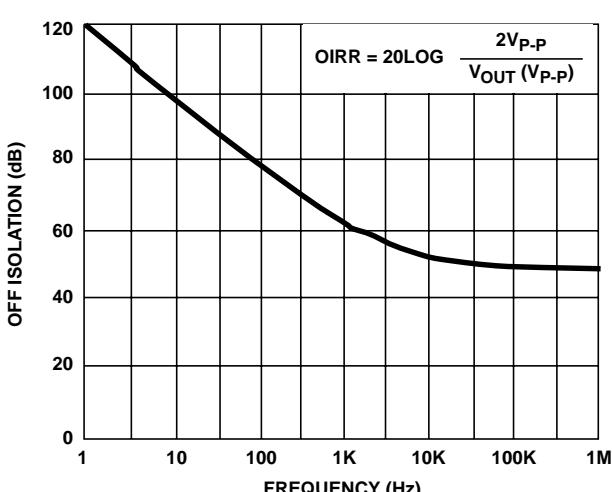


FIGURE 4A. OFF ISOLATION vs FREQUENCY

FIGURE 4. OFF ISOLATION

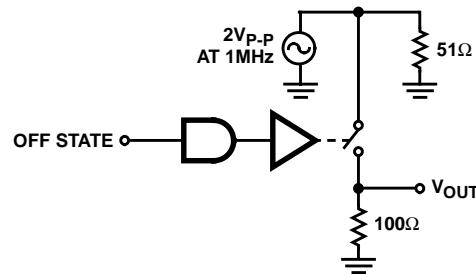


FIGURE 4B. TEST CIRCUIT

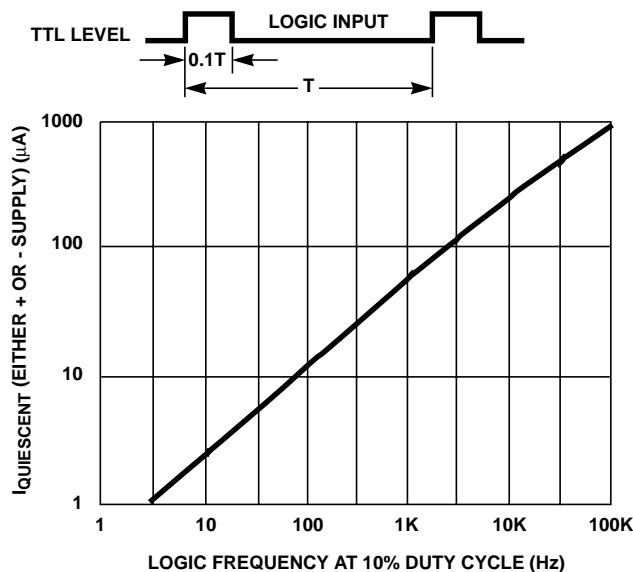
**Test Circuits and Waveforms (Continued)**

FIGURE 5. SUPPLY CURRENT vs LOGIC FREQUENCY

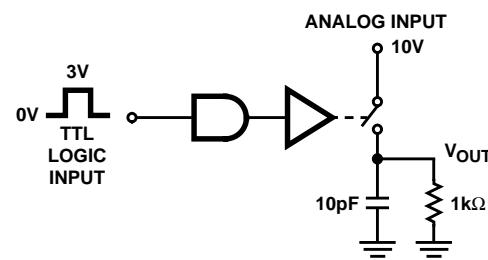
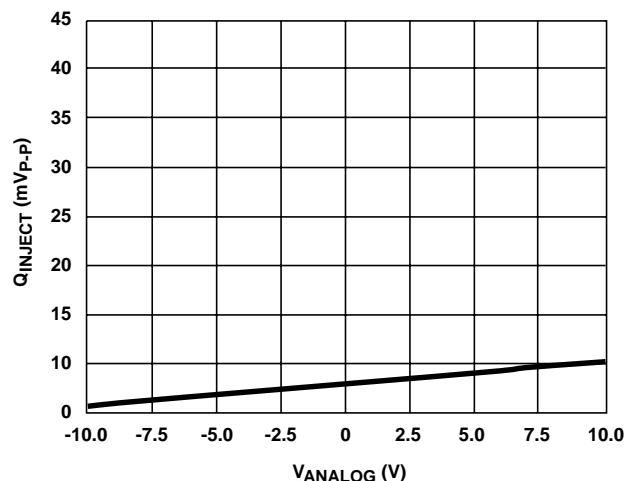
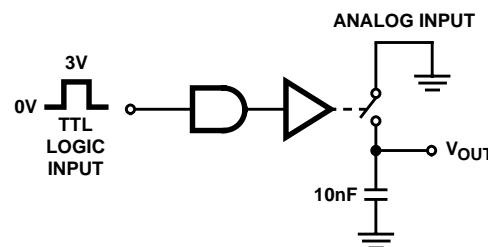
FIGURE 6. t<sub>ON</sub> AND t<sub>OFF</sub> TEST CIRCUITFIGURE 7A. CHARGE INJECTION vs ANALOG INPUT VOLTAGE, C<sub>L</sub> = 10nF

FIGURE 7B. TEST CIRCUIT

FIGURE 7. CHARGE INJECTION

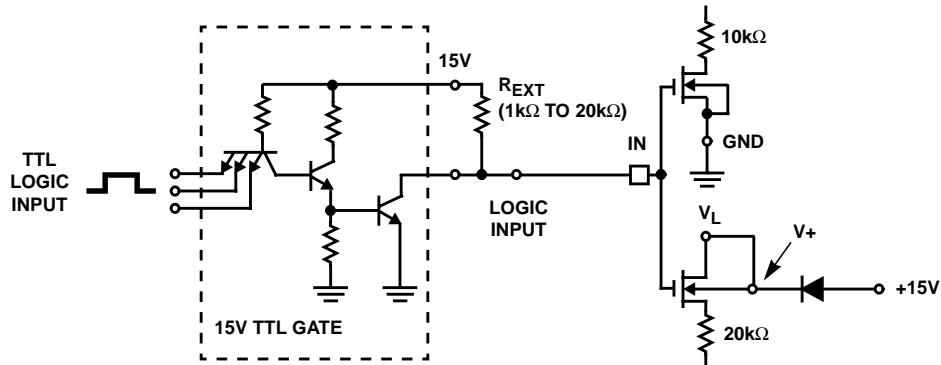
**Typical Applications**

FIGURE 8. +15V OPEN COLLECTOR TTL INTERFACE

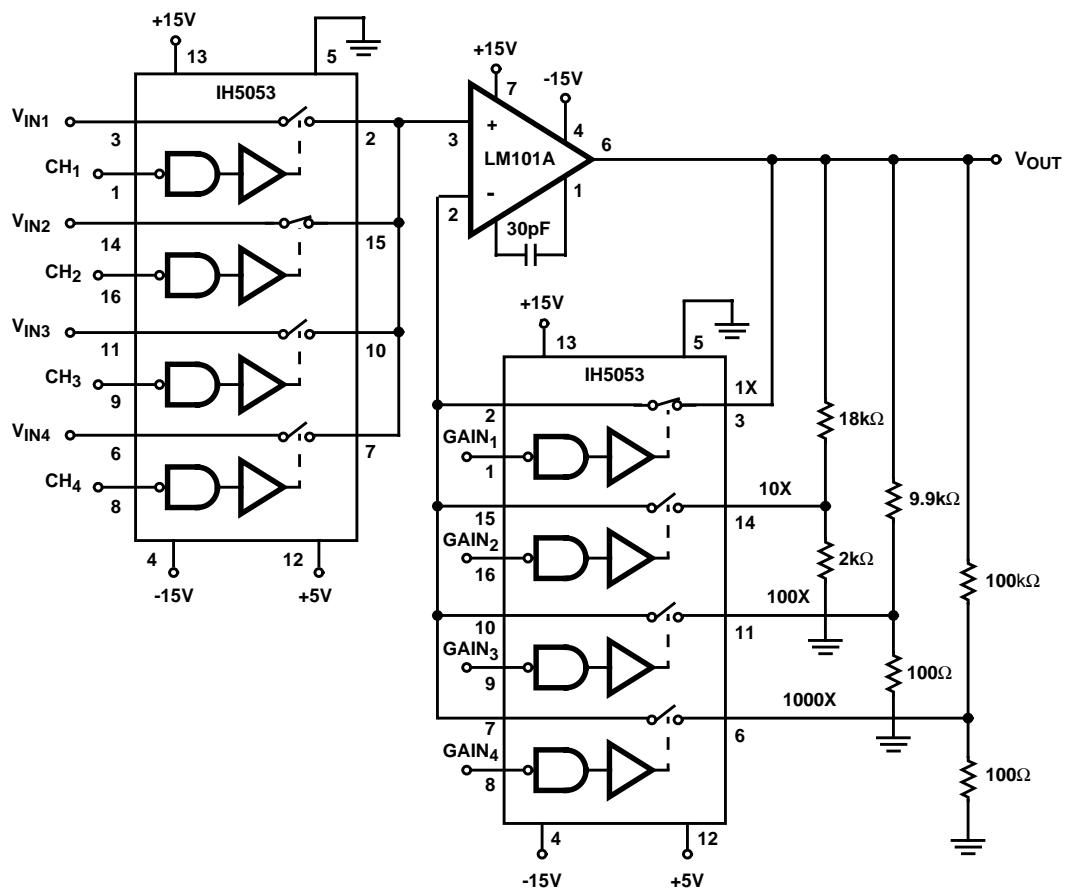


FIGURE 9. ACTIVE LOW PASS FILTER WITH DIGITALLY SELECTED BREAK FREQUENCY

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